Chip Scale Review

2018 Editorial Calendar

(Editorial close date: 11/20/2017	January • February	* indicates show distribution	
Enabling advanced applications in semiconductor packaging		SEMI European 3D Summit Dresden, Germany (Jan 22-24) SEMICON Korea Seoul, Korea (Jan 31-Feb 2) SMTA Pan Pac Microelectronics Symposium	
Challenges and solutions to driving fan-out into high volume			
Surface analysis as a blueprint for semiconductor package manufacturing			
Laser debonding for WLP		Waimea, Hawaii (Feb 5-8) • 2018 FLEX Monterey, CA (Feb 12-15) • APEX Expo	
Adhesives for advanced packaging			
Automotive sensing		San Diego, CA (Feb 27-Mar1) • ISS Europe	
3D heterogeneous integration		Dublin, Ireland, (Mar 4-6) BiTS Workshop* Mesa, AZ (March 4-7) IMAPS DPC* Fountain Hills, AZ (March 5-8) SEMICON China* Shanghai, China (March 14-16)	
3D bump inspection			
Improving efficiency in IC testing			
Reliability and thermal management			

Ad Space Close Jan 5 - Ad Materials Close Jan 12

(Editorial close date: 1/6)	March • April	* indicates show distribution	
OSATS market update		SEMICON SE Asia Kuala Lumpur, Malaysia (May 8-10) MEMS & Sensors Technical Congress Stanford, CA (May 10-11) ECTC * San Diego, CA (May 30- June 2)	
HD FO-WLP			
SiPs for increased functionality			
HVM lithography applications			
Smart innovations in automotive electronics			
Material supply challenges for future devices			
MEMS and sensor integration			
Advances in failure analysis			
Higher performance test solutions			

Ad Space Close Feb 10 - Materials Close Feb 15

(Editorial close date: 3/9)	May • June	* indicates show distribution
Next-gen IOT solutions		IEEE/SW Test Workshop (SWTW) San Diego, CA (June 3-6) Sensors Expo San Jose, CA (June 26-28) SEMICON West * San Francisco, CA (July 10-12)
Underfill and encapsulation		
Die attach		
TSVs		
Metrology for stress analysis		
Smart burn-in & test sockets		
Critical processes for fan-out		
Trends in Cu pillar		
Innovative IC trends in the China		

Ad Space Close May 19 - Ad Materials Close May 24